Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/508,876	MATSUSHIMA ET AL.	MATSUSHIMA E	
Examiner	Art Unit	Art Unit	
David Buttner	1712	1712	

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inventor search	7/3/20	006 DB	
chem ab	7/3/20	006 DB	
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